

Notice of References Cited		Application/Control No. 10/689,209	Applicant(s)/Patent Under Reexamination SHUKLA ET AL
	Examiner Lien T. Tran	Art Unit 1761	Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-6,149,962	11-2000	Loh et al.	426/573
	B	US-			
	C	US-			
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